

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BAJKO ET AL.	
		Examiner Khai M. Nguyen	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2005/0009520 A1	01-2005	Herrero et al.	455/435.1
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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